



**WANSEMI**  
万芯半导体

**WP8205AT8**

# **Enhancement Mode N-Channel Power MOSFET**

TSSOP8/NMOS/20V/ $\pm 12$ V/0.7V/6A/20m $\Omega$

Rev1.4

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## 20V, 20mΩ, 6A, N-Channel MOSFET

### 1.Features

- ◆ 20V MOSFET technology
- ◆ Low on-state resistance
- ◆ Fast switching
- ◆  $V_{GS} \pm 12V$

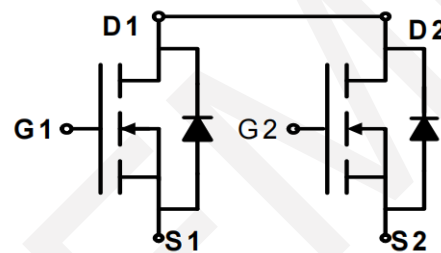
$V_{DS}$	$R_{DS(on)}$ Typ.	$I_D$ Max.
20V	20mΩ @ 4.5V	6A
	24.4mΩ @ 2.5V	

### 2.Applications

- ◆ Power Switching Application
- ◆ Load Switching



TSSOP8  
Pin Description



Schematic Diagram

### 3.Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP8205AT8	8205A	TSSOP8	5,000	80,000

### 4.Absolute Max Ratings at $T_a=25^\circ C$ (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{DSS}$	20	V
Gate to Source Voltage	$V_{GSS}$	$\pm 12$	V
Drain Current (DC)	$I_D$	6	A
Drain Current (Pulse), $PW \leq 300\mu s$	$I_{DP}$	25	A
Total Dissipation	$P_D$	1.5	W
Junction Temperature	$T_j$	150	$^\circ C$
Storage Temperature	$T_{stg}$	-55 to +150	$^\circ C$

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

**5. Thermal Resistance Ratings (Note 2)**

Parameter	Symbol	Value	Unit
Junction to Ambient	$R_{\theta JA}$	83	$^{\circ}C/W$

Note 2: When mounted on 1 inch square copper board  $t \leq 10$ sec The value in any given application depends on the user's specific board design.

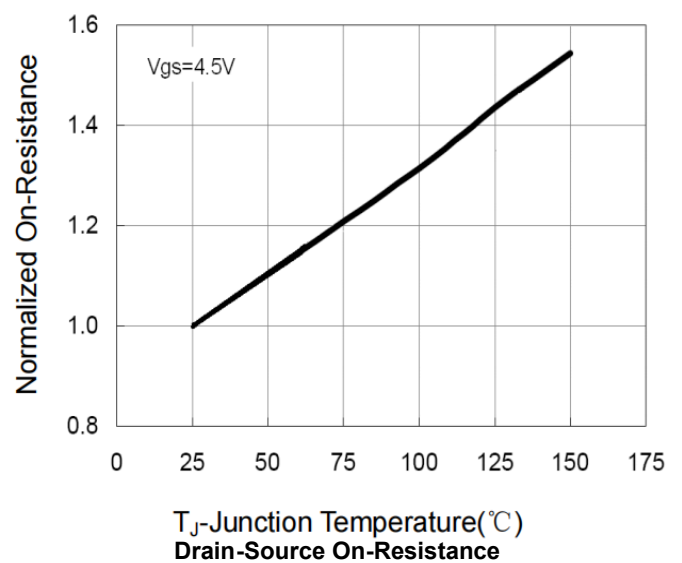
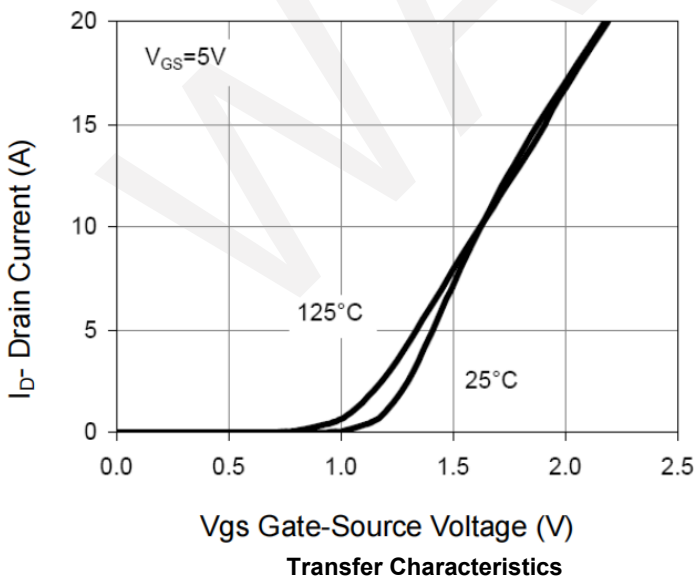
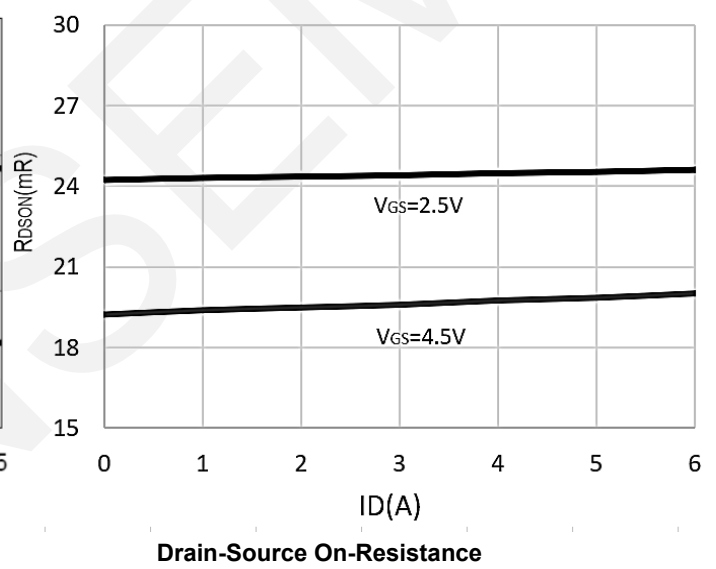
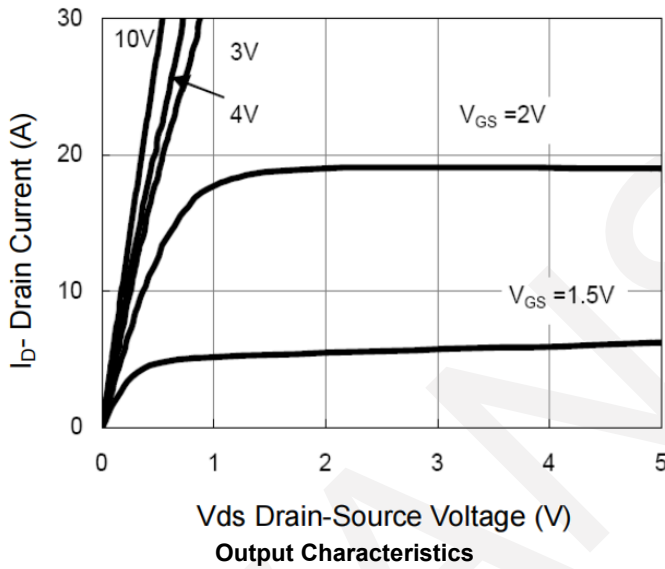
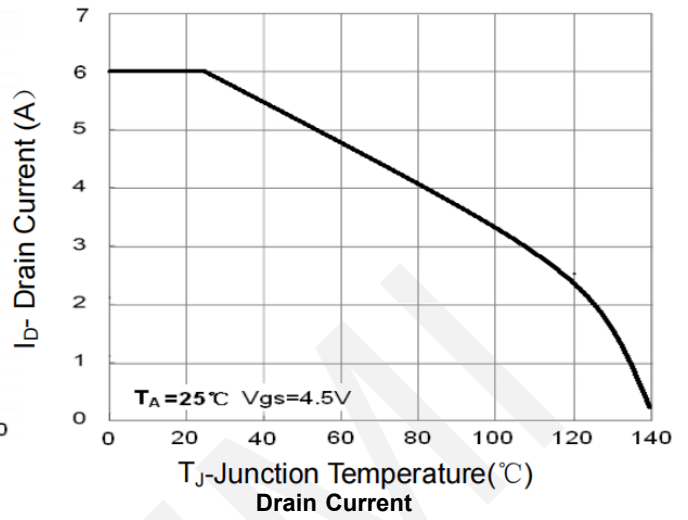
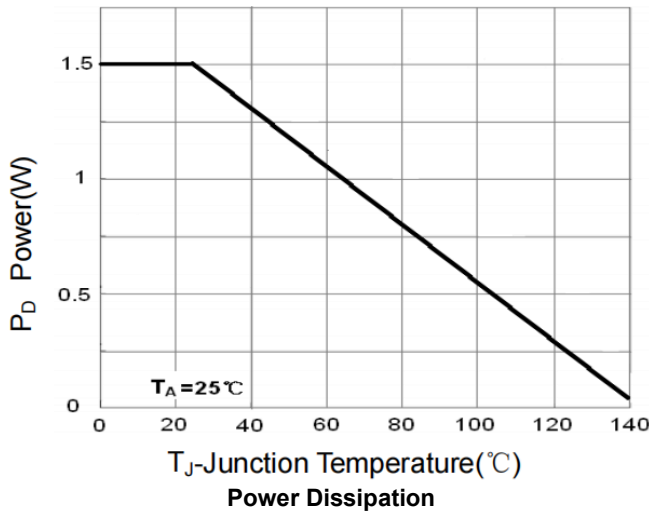
**6. Electrical Characteristics at  $T_a=25^{\circ}C$  (Note 3)**

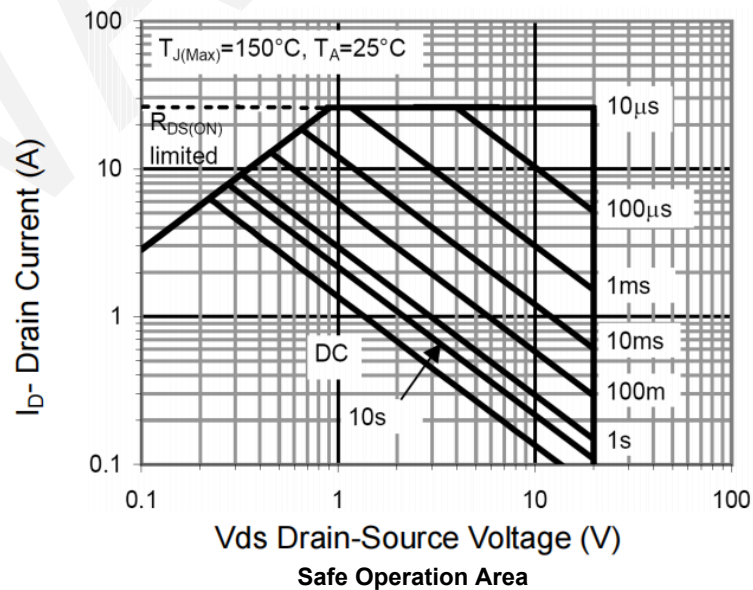
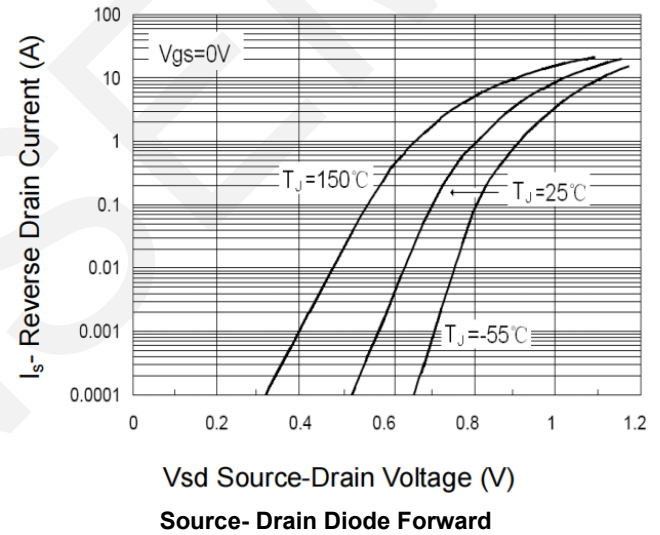
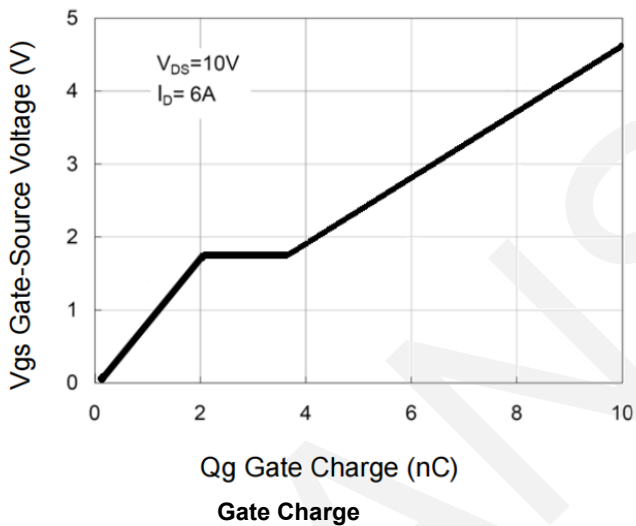
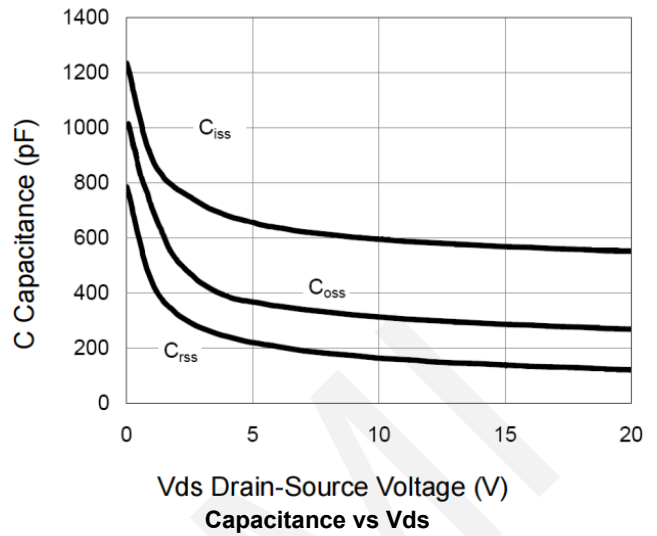
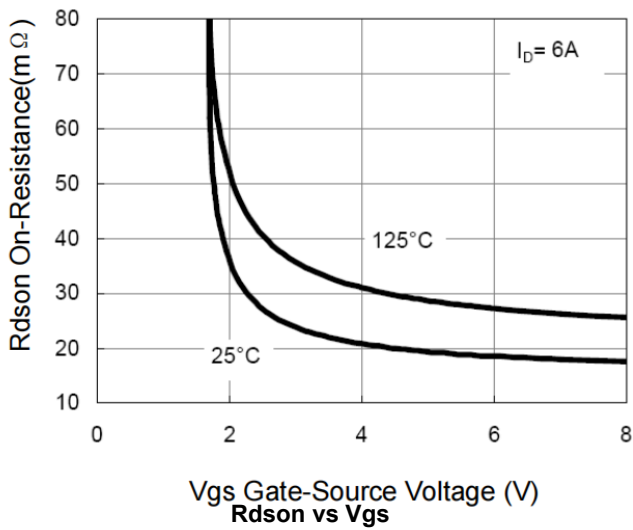
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250\mu A, V_{GS} = 0V$	20	-	-	V
Zero-Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 19V, V_{GS} = 0V$	-	-	1	$\mu A$
Gate to Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 12V, V_{SS} = 0V$	-	-	$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	0.5	0.7	1.1	V
Static Drain to Source On-State Resistance	$R_{DS(on)}$	$I_D = 6A, V_{GS} = 4.5V$	-	20	23	m $\Omega$
		$I_D = 3A, V_{GS} = 2.5V$	-	24.4	30	m $\Omega$
Input Capacitance	$C_{iss}$	$V_{GS}=0V,$ $V_{DS}=10V,$ Frequency=1.0MHz	-	900	-	pF
Output Capacitance	$C_{oss}$		-	220	-	pF
Reverse Transfer Capacitance	$C_{rss}$		-	100	-	pF
Turn-ON Delay Time	$t_{d(on)}$		-	10	-	ns
Rise Time	$t_r$	$V_{DD} = 10V, I_D = 1A,$ $V_{GS} = 4.5V, R_G = 6\Omega$	-	11	-	ns
Turn-OFF Delay Time	$t_{d(off)}$		-	35	-	ns
Fall Time	$t_f$		-	30	-	ns
Total Gate Charge	$Q_g$	$V_{DS} = 10V,$ $V_{GS} = 4.5V,$ $I_D = 6A$	-	12	-	nC
	$Q_{gs}$		-	2.5	-	nC
	$Q_{gd}$		-	1.5	-	nC
Diode Forward Voltage	$V_{FSD}$	$I_S = 6A, V_{GS} = 0V$	0.4	0.8	1.2	V

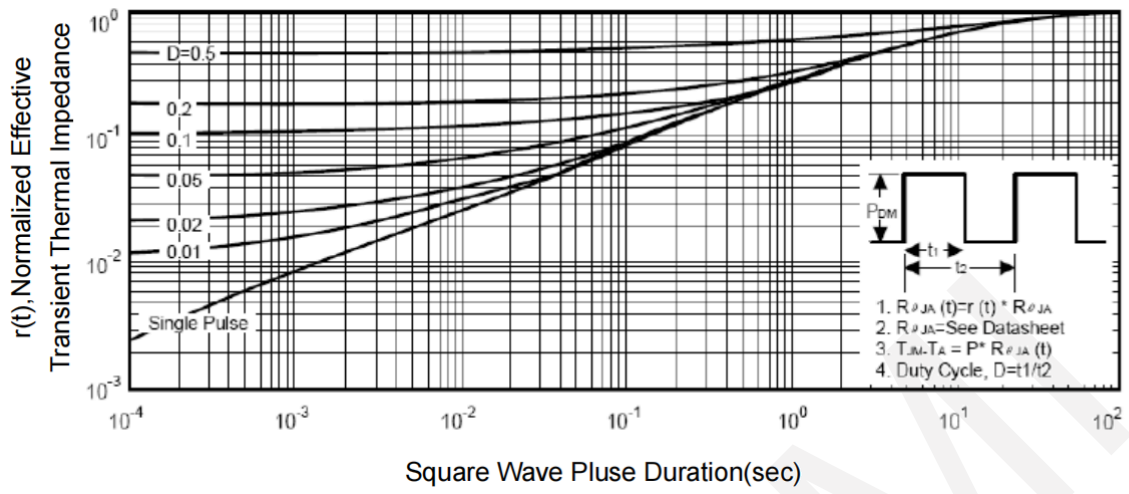
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



### 7. Typical electrical and thermal characteristics



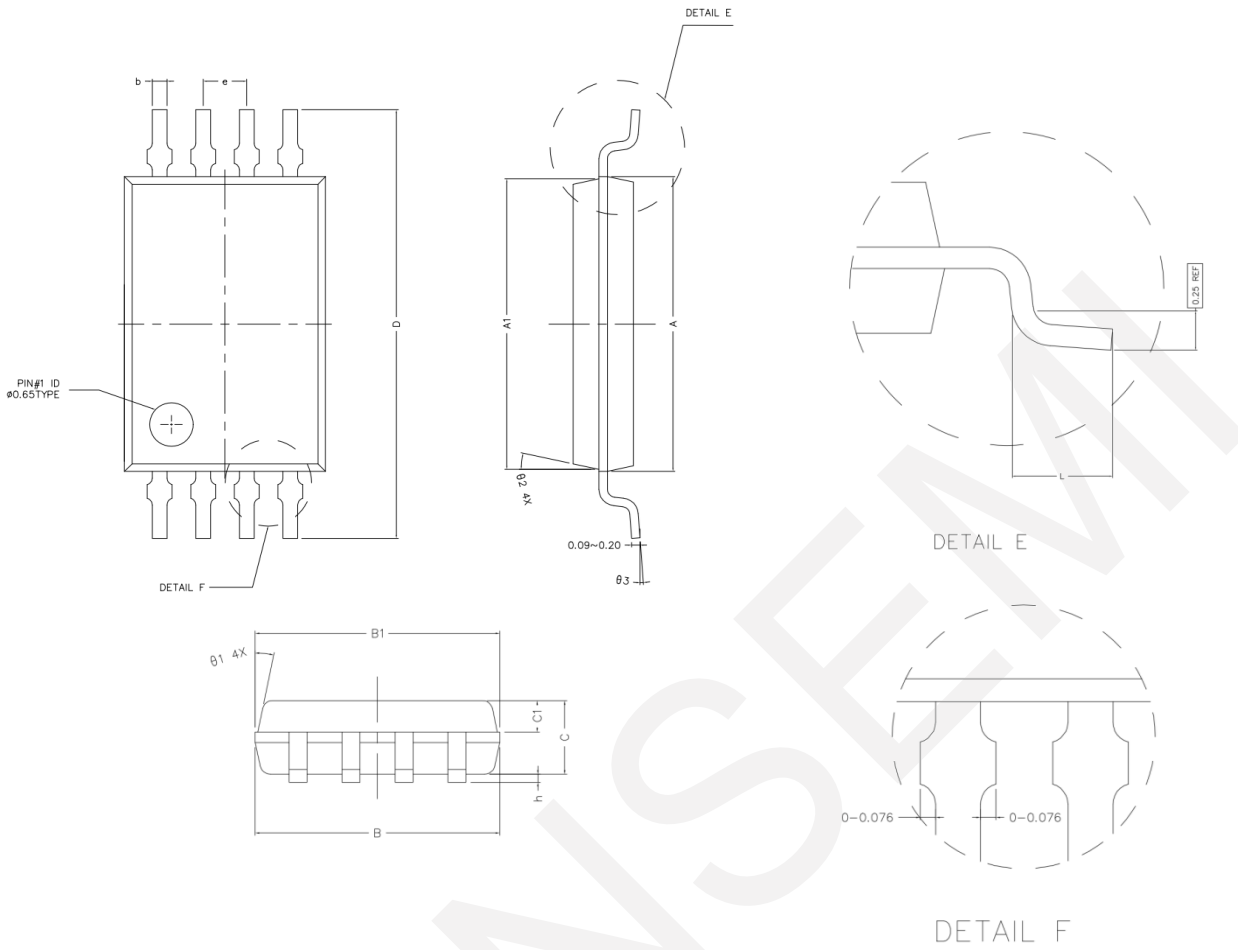




Normalized Maximum Transient Thermal Impedance



**8.Package Dimensions**



COMMON DIMENSIONS (UNITS OF MEASURE IS mm)			
	MIN	NORMAL	MAX
A	4.300	4.400	4.500
A1	4.240	4.340	4.440
B	2.900	3.000	3.100
B1	2.840	2.940	3.040
C	0.850	0.900	0.950
C1	0.337	0.387	0.437
D	6.250	6.400	6.550
L	0.450	0.600	0.750
b	0.170	0.220	0.300
h	0.050	0.100	0.150
e	0.650TYPE		
$\theta_1$	12° TYPE		
$\theta_2$	12° TYPE		
$\theta_3$	0° ~ 7°		

## 9. Important Notice

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